

Notice of References Cited	Application/Control No. 10/530,799	Applicant(s)/Patent Under Reexamination GAID ET AL.	
	Examiner Christopher Upton	Art Unit 1724	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,364,534	11-1994	Anselme et al.	210/195.2
*	B	US-4,956,093	09-1990	Pirbazari et al.	210/616
*	C	US-5,932,099	08-1999	Cote et al.	210/631
*	D	US-4,076,615	02-1978	Olesen et al.	210/631
*	F	US-4,919,815	04-1990	Copa et al.	210/616
*	F	US-4,810,386	03-1989	Copa et al.	210/616
*	G	US-5,068,036	11-1991	Li et al.	210/616
*	H	US-5,254,253	10-1993	Behmann, Henry	210/195.2
*	I	US-4,610,792	09-1986	Van Gils et al.	210/694
*	J	US-5,552,055	09-1996	Arato, George J.	210/694
*	K	US-5,204,001	04-1993	Tonelli et al.	210/151
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
✕	N	JP 6-226294	08-1994	Japan	-	-
✕	O	JP 2002-192184	07-2002	Japan	-	-
✕	P	FR 2770210	04-1999	France	-	-
✕	Q	FR 2737202	01-1997	France	-	-
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.